## A linear sampling method for recovering a clamped cavity in a thin plate Purdue Graduate Research Day

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## Overview



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### Ongoing Future Work

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## Inverse Shape Problem

- Send a wave and observe the reflected wave by an unknown obstacle
- Question: What information about the obstacle can one extract from the observed wave?
- Type of waves: flexural waves in elastic plates (biharmonic plate equation)
- **Applications:** nondestructive testing and designing devices for remote sensing, energy harvesting, and vibration isolation.



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Model Equation for Thin Plate Bending

Model of out-of-plane displacement in a thin elastic plate

$$\mathcal{D}\Delta^2 W + \rho h \frac{\partial^2 W}{\partial t^2} = 0$$

• 
$$\mathcal{D} \coloneqq \frac{Eh^3}{12(1-\nu^2)}$$
: flexural rigidity

- E > 0: Young's modulus
- $\nu \in [0, \frac{1}{2})$ : Poisson's ratio
- h: thickness
- ρ: density of material

**Time-Harmonic** Dependency:  $W(x,t) = \operatorname{Re}\{u(x)e^{-i\omega t}\}$ 

**Time-Harmonic Biharmonic Plate Equation** 

$$\Delta^{2}u - \kappa^{4}u = 0, \quad \kappa^{2} = \sqrt{\frac{\rho h \omega}{D}} : \text{ wave number}$$

## Direct and Inverse Scattering of Biharmonic Waves

Problem (The Direct Clamped Cavity Scattering Problem)

We consider the time-harmonic biharmonic scattering problem

- **9**  $D \subset \mathbb{R}^2$  is a clamped (fixed) cavity with  $\partial D \in C^{\infty}(\mathbb{R}^2)$
- **(a)** The cavity receives illumination from the incident plane wave  $u^i(x) = \exp(i\kappa x \cdot d)$

The total field  $u = u^i + u^s \in H^2_{loc}(\mathbb{R}^2)$  satisfies, with r = |x|,

$$\begin{cases} \Delta^2 u - \kappa^4 u = 0 \quad \text{in } \mathbb{R}^2 \setminus \overline{D} \\ u = 0, \quad \partial_n u = 0 \quad \text{on } \partial D \\ \lim_{r \to \infty} \sqrt{r} \left( \partial_r u^s - i\kappa u^s \right) = 0, \quad \lim_{r \to \infty} \sqrt{r} \left( \partial_r \Delta u^s - i\kappa \Delta u^s \right) = 0 \text{ (SRC)} \end{cases}$$
(1)

#### Remark

Let  $u^i = \exp(i\kappa x \cdot d)$  then the radiating scattered field  $u^s(x, d; \kappa)$  depends on the incident direction d and wave number k.

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Well-posedness of Direct Clamped Cavity Scattering Problem

The well-posedness of the direct clamped cavity scattering problem has been studied:

Variational Method & Riesz-Fredholm theory

Bourgeouis, L. and Hazard, C. (2020), On Well-Posedness of Scattering Problems in a Kirchhoff-Love Infinite Plate, SIAM Journal on Applied Mathematics 80(3), 1546-1556.

Boundary Integral Equation Method & Riesz-Fredholm Theory

Li, P. and Dong, H. (2024), A Novel Boundary Integral Formulation for the Biharmonic Wave Scattering Problem, Journal of Scientific Computing 98(42), 1-29.

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Inverse Clamped Cavity Problem

The outgoing scattered field, also known as the radiating solution, satisfies

$$u^s(x) = \frac{e^{i\kappa r}}{\sqrt{r}} u^\infty(\hat{x}) + O\left(\frac{1}{r^{3/2}}\right) \quad \text{as } r = |x| \to \infty, \quad \hat{x} = x/r$$

 $u^\infty(\hat{x}):\mathbb{S}^1\to\mathbb{C}$  defined on the unit sphere is called the far-field pattern. Now define the far-field operator as

Definition (Far-Field Operator (aka Relative Scattering Operator))

$$\mathcal{F}\,:\,L^2(\mathbb{S}^1)\to L^2(\mathbb{S}^1),\quad (\mathcal{F}g)(\hat{x})=\int_{\mathbb{S}^1}u^\infty(\hat{x},d)g(d)\,ds(d).$$

 $\mathcal{F}g = u_g^{\infty}, \text{ where } u_g^{\infty} \text{ is the far-field pattern of the scattered field } u_g^s \text{ with incident} \\ \text{wave } v_g(x) \coloneqq \int_{\mathbb{S}^1} g(d) e^{i\kappa x \cdot d} \, ds(d) \text{ (Hergotz wave function)} \\ \text{Inverse clamped cavity problem: Given } \mathcal{F} \text{ for a range of wave numbers } \kappa \text{ obtain} \\ \text{qualitative information about the clamped cavity } D \text{ in a thin elastic plate.} \end{cases}$ 

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**Biharmonic Wave Decomposition** 

Consider the two auxiliary functions

$$u_H^s = -\frac{1}{2\kappa^2}(\Delta u^s - \kappa^2 u^s), \quad u_M^s = \frac{1}{2\kappa^2}(\Delta u^s + \kappa^2 u^s)$$

 $u^s_H$  is the Helmholtz component of  $u^s$  and  $u^s_M$  is the modified Helmholtz component of  $u^s$  such that

$$u^s=u^s_H+u^s_M,\quad \Delta u^s=\kappa^2(u^s_M-u^s_H)$$

 $\boldsymbol{u}_{H}^{s}$  and  $\boldsymbol{u}_{M}^{s}$  satisfy the Helmholtz equation and modified Helmholtz equation respectively

$$\Delta u_{H}^{s} + \kappa^{2} u_{H}^{s} = 0, \quad \Delta u_{M}^{s} - \kappa^{2} u_{M}^{s} = 0 \quad \text{in } \mathbb{R}^{2} \setminus \overline{D}$$

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**Biharmonic Wave Decomposition** 

We can reformulate the scattering problem (1) as

$$\begin{cases} \Delta u_H^s + \kappa^2 u_H^s = 0, \quad \Delta u_M^s - \kappa^2 u_M^s = 0 \quad \text{in } \mathbb{R}^2 \setminus \overline{D} \\ u_H^s + u_M^s = -u^i, \quad \partial_n u_H^s + \partial_n u_M^s = -\partial_n u^i \quad \text{on } \partial D \\ \lim_{r \to \infty} \sqrt{r} \left( \partial_r u_H^s - i\kappa u_H^s \right) = 0 \\ \lim_{r \to \infty} \sqrt{r} \left( \partial_r u_M^s - i\kappa u_M^s \right) = 0, \quad r = |x| \end{cases}$$
(2)

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Biharmonic Wave Decomposition

We can reformulate the scattering problem (1) as

$$\begin{cases} \Delta u_H^s + \kappa^2 u_H^s = 0, \quad \Delta u_M^s - \kappa^2 u_M^s = 0 \quad \text{in } \mathbb{R}^2 \setminus \overline{D} \\ u_H^s + u_M^s = -u^i, \quad \partial_n u_H^s + \partial_n u_M^s = -\partial_n u^i \quad \text{on } \partial D \\ \lim_{r \to \infty} \sqrt{r} \left( \partial_r u_H^s - i\kappa u_H^s \right) = 0 \\ \lim_{r \to \infty} \sqrt{r} \left( \partial_r u_M^s - i\kappa u_M^s \right) = 0, \quad r = |x| \end{cases}$$
(2)

#### Remark (Exponential Decay of $u_M^s$ )

 $u_M^s$  and  $\partial_r u_M^s$  exhibit exponential decay as  $r = |x| \to \infty$  for the fixed wavenumber  $\kappa$  as  $\kappa r \to \infty$ . Specifically,  $u_M^s$  satisfies

$$u^s_M(x) = O\left(\frac{e^{-kr}}{\sqrt{r}}\right), \, r \to \infty$$

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Far-Field Pattern of the Biharmonic Scattered Field

Because of the exponential decay of the evanescent part  $u^s_M$  and  $\partial_n u^s_M$ , the far-field pattern contains only information about the Helmholtz component, thus,

$$u^{\infty}(\hat{x}) = u_H^{\infty}(\hat{x}),$$

up to a constant depending on  $\kappa.$  By Rellich's lemma and exp. decay of  $u^s_M\text{,}$  we obtain

#### Lemma (P.Li & H.Dong, 2023)

if  $u^s \in C^4(\mathbb{R}^2 \setminus \overline{D})$  satisfies

$$\lim_{r \to \infty} \int_{|x|=r} |u^s(x)|^2 \, ds = 0,$$

then  $u_H^s = 0$  in  $\mathbb{R}^2 \setminus \overline{D}$ . Thus,

$$u^{\infty}=0\implies u^s_H=0 \text{ in } \mathbb{R}^2\setminus\overline{D}.$$

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## **Reconstruction Methods**

- Iterative methods to determine D (expensive optimization; a good initial guess is needed; only one or a few incident waves are needed; reconstructions are reasonably good)
- Obmain decomposition methods (solve an ill-posed linear integral equation first to reduce computational expense, then optimize)
- Oirect imaging methods (avoid optimization entirely, solve many ill-posed integral equations, requires a lot of multistatic data but no a priori information; partial qualitative information about the scatterer is obtained)

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## Reconstruction of D via Direct Imaging Methods

#### Remark (Shape Reconstruction)

**Direct Imaging Methods**: the idea is to construct an indicator test function I that will test whether a point z lies inside or outside the scatterer. **Benefits:** can reconstruct the shape of the scatterer in a computational simple manner with **no a priori information**.

- Assume only the location and shape of the object is needed (e.g., looking for a crack or cavity).
- $\bullet\,$  Based on model, derive an indicator test function I(z), depending on coordinates, so that

$$T(z) = \begin{cases} 0, & z \notin \text{ object} \\ 1, & z \in \text{ object} \end{cases}$$

• I(z) must be fast to compute from the scattered or far-field data.

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Categorizing Direct Imaging Methods



Figure: Approaches to Qualitative Imaging

- '96 Colton Kirsch: linear sampling method, factorization (point sampling in grid)
- '98 Ikehata: probing method (curve); '00 Potthast: singular source method (curve/needle)
- ... Luke, Potthast, Sylvester, Kusiak, Ikehata: range test, no response test, enclosure method (sets/planes)

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## Results on Inverse Shape Problem for Biharmonic Plate Equation

- L. Bourgeouis & A. Recoquillay (2020): recovery of clamped cavities and cavities in a free plate with the linear sampling method with near-field measurements (boundary measurements)
   Disadvantage: uses far more multistatic data, namely scattered field and normal derivative of scattered field for point source and dipole
- Y. Chang & Y. Guo (2023): recovery of clamped cavities in a thin elastic plate with near field measurements via the domain decomposition method (optimization method)
- I. Harris, P. Li, & H. Lee (2024): recovery and resolution analysis of clamped cavities with the direct sampling method
- A. Karageorghis & D. Lesnic (2024): method of fundamental solutions (iterative method) for recovering clamped and free plate cavities with near field measurements

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## Uniqueness Result

#### Theorem (P. Li & H. Dong, 2023)

Let  $D_1$  and  $D_2$  be two cavities meeting the clamped boundary conditions, with corresponding far-field patterns  $u_1^\infty$  and  $u_2^\infty$  satisfying

$$u_1^{\infty}(\hat{x}, d) = u_2^{\infty}(\hat{x}, d), \quad \forall \hat{x}, d \in \mathbb{S}^1.$$

Then  $D_1 = D_2$ .

- This result guarantees uniqueness of the inverse cavity scattering problem with clamped boundary conditions.
- Proof of the result is based on the reciprocity relations and correspondences of the far-field patterns with respective scattered fields generated by point sources.

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Idea Behind Linear Sampling Method

# Qualitative/Sampling Scheme Goal: want to

• recover shape and location of the cavity using an indicator function based on an integral equation solution

Sampling: Collect the far-field data  $u^\infty$  and solve an ill-posed linear integral equation for each sample point z



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Core of LSM - The Far-Field Equation

#### **Far-Field Equation**

$$\mathcal{F}g_{z}(\hat{x}) = \Phi^{\infty}(\hat{x}, z), \quad \Phi^{\infty}(\hat{x}, z) = -\frac{1}{2\kappa^{2}} \frac{e^{i\pi/4}}{\sqrt{8\kappa\pi}} e^{-i\kappa x \cdot z}, \, g_{z} \in L^{2}(\mathbb{S}^{1}), \, z \in \mathbb{R}^{2}$$

- $\Phi^\infty(\cdot,z)={\rm FF}$  pattern of the point source  $\Phi(\cdot,z)$  centered at sampling point z
- $\Phi(\cdot,z)$  satisfies  $(\Delta^2 \kappa^4)\Phi(\cdot,z) = (\Delta \kappa^2)(\Delta + \kappa^2)\Phi(\cdot,z) = -\delta(\cdot z)$  in  $\mathbb{R}^2$  with

$$\begin{split} \Phi(x,z) &= \frac{i}{8\kappa^2} \left( H_0^1(\kappa |x-z|) + \frac{2i}{\pi} K_0(\kappa |x-z|) \right), \quad x \neq z \\ &= \frac{1}{2\kappa^2} (\Phi_H(x,z) - \Phi_M(x,z)), \end{split}$$

where  $H_0^{(1)}$  and  $K_0$  are the Hankel functions of the first kind and MacDonald's function, respectively.

•  $\mathcal{F}$  is a compact operator, so the FF equation is **ill-posed**.

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Approximate Solvability Condition of Far-Field Equation

Want an approximate solvability condition for the FF equation:

#### Problem

Approximate Solvability Condition: want to show  $\mathcal{F}$  has dense range in  $L^2(\mathbb{S}^1)$ ; that is,

$$\overline{\text{Range }\mathcal{F}}^{||\cdot||_{L^2(\mathbb{S}^1)}} = L^2(\mathbb{S}^1)$$

By Hahn-Banach Theorem, this is equivalent to showing the adjoint operator  $\mathcal{F}^*$  is injective. By a result called the **reciprocity relation**, the approximate solvability condition reduces to showing  $\mathcal{F}$  is injective.

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Approximate Solvability and Reciprocity Relation

#### Lemma (Reciprocity Relation)

 $u^{\infty}(\hat{x}, d) = u^{\infty}(-d, -\hat{x})$  for every  $\hat{x}, d \in \mathbb{S}^1$ .

Proof uses Green's representation formula for  $u^\infty + {\rm exploits \; exp. \; decay \; of \; } u^s_M.$  Why is this useful?

$$\begin{split} (f,\mathcal{F}g)_{L^2(\mathbb{S}^1)} &= \int_{\mathbb{S}^1} \left( \overline{\int_{\mathbb{S}^1} u^{\infty}(\hat{x},d)g(d)\,ds(d)} \right) \, ds(\hat{x}) \\ &= \int_{\mathbb{S}^1} \left( \overline{\int_{\mathbb{S}^1} u^{\infty}(-d,-\hat{x})g(d)\,ds(d)} \right) \, ds(\hat{x}) \\ &= \left( \overline{u^{\infty}(-d,-\hat{x})}f(\hat{x})ds(\hat{x}),g \right)_{L^2(\mathbb{S}^1)}, \end{split}$$

so  $\mathcal{F}^*g = \overline{R\mathcal{F}Rg}$  where  $(Rf)(\hat{x}) := f(-\hat{x})$ . Approximate Solvability: Suffices to show  $\mathcal{F}$  is injective!

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Assumption for Approximate Solvability

We want to determine when  $\mathcal{F}$  is injective. Suppose  $\mathcal{F}g = u_g^\infty = 0$ . Then by Rellich's lemma + exp. decay of the modified Helmholtz component,

$$u^s_{g,H}(x) = \int_{\mathbb{S}^1} u^s_H(x,d) g(d) \, ds(d) = 0 \, \text{ in } \mathbb{R}^2 \setminus \overline{D},$$

with

$$\begin{aligned} \Delta u^s_{g,M} &- \kappa^2 u^s_{g,M} = 0 \text{ in } \mathbb{R}^2 \setminus \overline{D}, \\ \Delta u^s_{g,H} &+ \kappa^2 u^s_{g,H} = 0 \text{ in } D, \end{aligned}$$
 (3)

and so on the boundary  $\partial D$ :

$$u_{g,M}^{s} + v_{g} = 0, \quad \partial_{n}(u_{g,M}^{s} + v_{g}) = 0.$$
 (4)

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Assume:  $\kappa^2 \neq$  eigenvalue of (3)–(4) to ensure  $v_g = 0$  on  $\partial D$ , so that g = 0. (Only want trivial solution pair)

Helpful Auxiliary Operators for Approximate Solvability

Define the Herglotz wave operator

$$\mathcal{H}: L^2(\mathbb{S}^1) \to H^{3/2}(\partial D) \times H^{1/2}(\partial D) : g \mapsto \begin{pmatrix} v_g \\ \partial_n v_g \end{pmatrix} \Big|_{\partial D},$$

where  $v_g(x) = \int_{\mathbb{S}^1} e^{i\kappa x\cdot d}g(d)\,ds(d)$  is the Herglotz wave function. Then

$$\mathcal{F} = -\mathcal{GH}$$

- $\mathcal{G}$ : boundary data  $\mapsto$  FF pattern (data-to-pattern operator)
- $\bullet \ {\mathcal H}$  is the Herglotz wave operator that maps g to the superposition of plane wave data on the boundary.
- By superposition  $\mathcal{H}g$  induces the far-field pattern  $\mathcal{F}g$

On Auxiliary Operator  $\mathcal{G}$ 

- $\mathcal{G}: H^{3/2}(\partial D) \times H^{1/2}(\partial D) \to L^2(\mathbb{S}^1): (h_1, h_2)^\top \mapsto w^\infty$ 
  - $\begin{tabular}{ll} \bullet & w^\infty = {\rm far-field \ pattern \ of \ the \ unique \ radiating \ solution \ w \in H^2_{\rm loc}(\mathbb{R}^2 \setminus \overline{D}) \\ & {\rm satisfying \ } \end{tabular}$

$$\begin{cases} \Delta^2 w - \kappa^4 w = 0 \quad \text{in } \mathbb{R}^2 \setminus \overline{D}, \\ w|_{\partial D} = h_1, \quad \partial_n w|_{\partial D} = h_2, \\ \lim_{r=|x|\to\infty} \sqrt{r} \left(\partial_r w - i\kappa w\right) = 0, \lim_{r=|x|\to\infty} \sqrt{r} \left(\partial_r \Delta w - i\kappa \Delta w\right) = 0 \end{cases}$$
(5)

**②** To show  $\mathcal{G}$  is injective, we need to assume that  $\kappa^2 \neq$  eigenvalue of the mixed eigenvalue problem given by the pair  $(p,q) = (w_M, u^i)$  satisfying

$$\begin{cases} \Delta p - \kappa^2 p = 0 \quad \text{in } \mathbb{R}^2 \setminus \overline{D}, \\ \Delta q + \kappa^2 q = 0 \quad \text{in } D, \\ p + q = 0, \quad \partial_n (p + q) = 0 \quad \text{on } \partial D, \\ \lim_{r = |x| \to \infty} \sqrt{r} \left( \partial_r p - i\kappa p \right) = 0, \end{cases}$$
(6)

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## Approximate Solvability of the FF equation

The following two lemmas ensure the approximate solvability condition of the far-field equation holds:

#### Lemma (G. Ozochiawaeze, 2024)

The auxiliary operator  $\mathcal{G}$  is compact with dense range on  $L^2(\mathbb{S}^1)$ . Moreover, if  $\kappa^2 \neq$  eigenvalue of (6), then  $\mathcal{G}$  is injective. Finally, we have the following range characterization of the clamped cavity D:

 $z \in D \iff \Phi^{\infty}(\hat{x}, z) \in \mathsf{Range}(\mathcal{G}).$ 

#### Lemma (G. Ozochiawaeze, 2024)

 $\mathcal{H}$  is compact and injective. If  $\kappa^2 \neq$  eigenvalue of (6), then  $\mathcal{F}$  is injective. Thus,  $\mathcal{F}$  has dense range in  $L^2(\mathbb{S}^1)$ .

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Range Characterization of the Cavity D

The **linear sampling method** is a direct imaging method based on the following range characterization of the cavity D:

Lemma (Range Characterization of Clamped Cavity D)

 $z \in D$  if and only if  $\Phi^{\infty}(\hat{x}, z) \in \mathsf{Range}(\mathcal{G})$ .

This result follows by Rellich's lemma and justifies the choice of indicator test function of LSM:

$$I(z) \coloneqq \frac{1}{||g_z||_{L^2(\mathbb{S}^1)}} = \begin{cases} 0, \text{ if } z \in \mathbb{R}^2 \setminus D, \\ > 0, \text{ if } z \in D. \end{cases}$$

Moreover,  $I(z) \rightarrow 0$  as  $z \rightarrow \partial D$ .

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## Reconstruction of the Cavity D via the LSM

#### Theorem (The Linear Sampling Method)

Assume  $\kappa \neq$  eigenvalue of the mixed eigenvalue problem (6). We have the following:

• Suppose  $z \in D$ . Given  $\epsilon > 0$  there exists an approximate solution  $g_{z,\epsilon} \in L^2(\mathbb{S}^1)$  to the far-field equation such that

$$||\mathcal{F}g_{z,\epsilon} - \Phi^{\infty}(\cdot, z)||_{L^2(\mathbb{S}^1)} < \epsilon.$$

Furthermore,  $||g_{z,\epsilon}||_{L^2(\mathbb{S}^1)}$  is unbounded as  $z \to \partial D$ .

• Suppose  $z \notin D$ . Then the approximate solution of the far-field equation  $g_{z,\epsilon}$  satisfies

 $||g_{z,\epsilon}||_{L^2(\mathbb{S}^1)}$  is unbounded as  $\epsilon \to 0$ , assuming that

$$||\mathcal{F}g_{z,\epsilon} - \Phi^{\infty}(\cdot, z)||_{L^2(\mathbb{S}^1)} \to 0 \quad \text{as } \epsilon \to 0.$$

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## Numerical Scheme

- Construct a grid of 'sampling points' T in a region known to contain the cavity D. Choose a regularization parameter  $\alpha > 0$  and cut-off constant  $c_0$ .
- For each grid point  $z_i \in \mathcal{T}$ , solve the regularized far-field equation  $(\alpha I + \mathcal{F}^* \mathcal{F})g_{z_i,\alpha} = \mathcal{F}^* \Phi^{\infty}(\hat{x}, z_i)$  (Tikhonov regularization)
- $\bullet$  Construct a reconstruction M for D where

$$M \coloneqq \{z_i \in \mathcal{T} : ||g_{z_i,\alpha}||_{L^2(\mathbb{S}^1)} \le c_0\}$$

Choice of  $c_0$  is heuristic; resolution improves with higher wave number. If we invert the indicator function,  $c_0 = 0$ .

Numerical Result: Recovering the Apple-Shaped Cavity





Figure: Recovering the Apple-Shaped Cavity with  $\kappa=2\pi;$  no noise; 30 incident and observation directions;  $250\times250$  grid

Figure: Recovering the Apple-Shaped Cavity with  $\kappa = 2\pi$ ; noise  $\delta = 0.02$ ; 30 incident and observation directions;  $250 \times 250$  grid

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Numerical Result: Recovering the Peach-Shaped Cavity





Figure: Recovering the Peach-Shaped Cavity with  $\kappa = \pi$ ; no noise; 30 incident and observation directions;  $250 \times 250$  grid

Figure: Recovering the Peach-Shaped Cavity with  $\kappa = \pi$ ; noise  $\delta = 0.05$ ; 30 incident and observation directions;  $250 \times 250$  grid

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Numerical Result: Recovering the Peanut-Shaped Cavity







Figure: Recovering the Peanut-Shaped Cavity with  $\kappa = 2\pi$ ; no noise; 30 incident and observation directions;  $250 \times 250$  grid

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Numerical Result: Recovering the Peanut-Shaped Cavity







Reconstruction with 5% error, N=128

Figure: Recovering the Peanut-Shaped Cavity with  $\kappa = \pi$ ; noise  $\delta = 0.05$ ; 128 incident and observation directions;  $250 \times 250$  grid

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## **Ongoing Future Work**

- numerical implementation of the linear sampling method for other cavities (e.g., free plate, simply supported plate, roller supported) based on Neumann and mixed boundary conditions with far-field data
- modification of the LSM for reconstructing cavities with a single incident plane wave (single measurement) (i.e., will consider the extended sampling method)

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